


Search Notes 	Application/Control No. 10511040	Applicant(s)/Patent Under Reexamination BARTH ET AL.
	Examiner Cho, Jennifer Y	Art Unit 1621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	7/8/07	JC
STIC Search	7/6/07	PS
Inventor Search	7/20/07	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner